





3D grain mapping using 3D detector at beamline ID11 at ESRF

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Outline

- Introduction
- Center of mass grain mapping
- 3D grain boundary mapping
- Results
- Future





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Why X-ray diffraction mapping?

- Grain evolution
- Many grains simultaneously
- X-rays scattered from crystal fulfilling the Bragg condition
- Monochromatic beam



refined from multi-crystal data





Experimental setup

Optics

- Focosing bent single laue crystal
- Double bent laue-laue monochromator

Detectors

- High resolution, Quantix (5 µm pixels)
- Low resolution, Frelon (50 μm pixels)





Detector images

Quantix detector

Frelon detector







Detector images

Frelon detector

Quantix detector





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Center of mass grain mapping

- Starting with farfield data
 - Peaksearching
 - Calculate G-vectors from peak positions
 - Assign G-vectors to grains
 - Refine the assignment
 - Evaluate the grains



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Center of mass grain mapping

- Starting with farfield data
 - Peaksearching
 - Calculate G-vectors from peak positions
 - Assign G-vectors to grains
 - Refine the assignment
 - Evaluate the grains
- Finding grains with the near field detector
 - Peaksearching
 - Calculate G-vectors from peak positions
 - Refine grains from farfield in the set of G-vectors from nearfield
 - Evaluate the grains





Center of mass grain map



Grain positions, orientations, lattice parameters all simultaneously refined from multi-crystal data

"grain boundaries" from Voronoi calculation: if the grain centre falls in the middle of the reconstructed grain, perhaps nothing is missing.





Center of mass grain map

• Some grain centres almost perfectly overlap, but have different orientations. Twins?





Furthermore, the average position would be at the centre of the total crystal

In this case, they share all <311>







Better representation?



Here the colours fall away from the centre of mass and end at the boundaries – so that missing or vacant areas become more apparent...







Could add some orientational information









Rotations after each step

Depicted are the Rodrigues vectors of subsequent rotations after straining a sample

Project with Toyota

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у (µm)

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x (µm)



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Also correlate with grain size distribution





These are constructed using only grains with a match above and/or below

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Center of mass grain map

Resistor: Compare different layers

• The grains found in different layers are compared based on their orientations and refined positions in order to try to locate the same grain in different layers.

 The results in this case are quite complete and unique: most grains match only one other grain in the next layer with precision <0.3° and 50 µm.



This can also give a sort of grain size distribution in z.







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Center of mass grain map

Combine layers to 3D center of mass grain map









GrainSweeper

- Define sample grid
- Scan orientation space
- Forward projections
- Grain completeness
- Connectivity search in sample grid
- Reconstruction of grain







Merge layers

- 3D connectivity search
- Merge on orientation and position

Layer #10





Layer #11

Combined layer #11-12



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- Grain Growth with C.E. Krill et al., Ulm University
- 1.4 mm diameter
- 1 mm height
- 100 layer with 10 μm height beam
- More than 1000 grains





Standards

- Within 24 hours of starting the setup it was possible to map 600 μm in height of a sample.
- Started setup at ~16.00
- 4 hours after at ~22.30 the first data was taken
- ~9.00 next morning data measurement was stopped
- This gives a center of mass grain map for each layer
- 3D grain reconstruction



- + A higher resolution on the quantix provides a more precise center of mass position for the grains.
- Inefficient phosphor screen on quantix leads to higher detection limit





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Projects

ID11 grain mapping of different samples











Projects

- ID11 grain mapping of different samples
 - Resistor
 - AI (AA1050)
 - Sucrose (part of the TotalCryst)
- AIMg
 - Grain Growth C.E. Krill, Ulm University
- Gum metal from Toyota
 - Grain rotations and grain break up Yoshiharu Hiriose
- Steel
 - Phase transitions S.E. Offerman, TUDelft
- NaCl
 - Grain growth Sandra Piazolo, Stockholm University





Summery

- Different grain mapping depend on needs
- Center of mass grain maps can be fast
- Grain boundary map for more than 1000 grains reconstructed
- 3D detector combining farfield and nearfield





Towards nano

What about smaller sizes, like a few microns?

One solution could be pointscanning 4N-AI_6cARB_Ann_EBSD







PointScanning

- Normally the beam illuminates the interesting area of the sample.
 - New area of sample moved onto the rotation center
 0.03
- In pointscanning the rotation center is move d_2
- Lines through the sample
- One rotation is not one data set but gvectors has to be recombined

-0.03 -0.04 -0.03 -0.02 -0.01 0 0.01 0.02 0.03 0.04

Can be used with nano sized beam

Beamsize 5 mµ x 5 mµ

0.01





Future

- High speed CMS mapping (few minuts each layer)
- Going from 'layer to layer' to box beam (100 μ m)
- Deformed 3D mapping
 - Software (new version of GrainSweeper)
 - High resolution 3D detector
- Micron and submicron mapping
 - Pointscanning with submicron beam





Collaborators

ID11 / ESRF

Gavin Vaughan Jon Wright Aleksei Bytchkov Caroline Curfs Henri Gleyzolle Jean-Michel Reynal Andy Götz Gaëlle Suchet Jean Michel Chaize Michel Rossat Denis Van Brussel

Totalcryst team at Risø Søren Schmidt Henning F. Poulsen Henning Osholm Sørensen **Ulm University** Carl E. Krill Toyota **Yoshiharu Hiriose** TUDelft Sven E. Offerman Stockholm University Sandra Piazolo